International Rectifier

- Surface Mount
- Dynamic dv/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Ease of Paralleling
- Advanced Process Technology
- Ultra Low On-Resistance
- Lead-Free

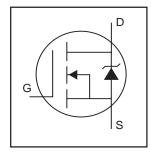
Description

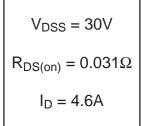
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The SOT-223 package is designed for surface-mount using vapor phase, infra red, or wave soldering techniques. Its unique package design allows for easy automatic pickand-place as with other SOT or SOIC packages but has the added advantage of improved thermal performance due to an enlarged tab for heatsinking. Power dissipation of 1.0W is possible in a typical surface mount application.

IRLL3303PbF

HEXFET® Power MOSFET







Absolute Maximum Ratings

	Parameter	Max.	Units				
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V**	6.5					
$I_D @ T_A = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V*	4.6	A				
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V*	3.7					
I _{DM}	Pulsed Drain Current ①	37					
P _D @T _A = 25°C	Power Dissipation (PCB Mount)**	2.1	W				
P _D @T _A = 25°C	Power Dissipation (PCB Mount)*	1.0	W				
	Linear Derating Factor (PCB Mount)*	8.3	mW/°C				
V _{GS}	Gate-to-Source Voltage	± 16	V				
E _{AS}	Single Pulse Avalanche Energy ^②	140	mJ				
I _{AR}	Avalanche Current①	4.6	Α				
E _{AR}	Repetitive Avalanche Energy®	0.10	mJ				
dv/dt	Peak Diode Recovery dv/dt 3	1.3	V/ns				
T _J , T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C				

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Amb. (PCB Mount, steady state)*	93	120	°C/W
$R_{\theta JA}$	Junction-to-Amb. (PCB Mount, steady state)**	48	60	C/VV

^{*} When mounted on FR-4 board using minimum recommended footprint.

^{**} When mounted on 1 inch square copper board, for comparison with other SMD devices. www.irf.com

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$	
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.034		V/°C	Reference to 25°C, I _D = 1mA	
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.031	Ω	$V_{GS} = 10V, I_D = 4.6A \oplus$	
TDS(on)				0.045	52	V _{GS} = 4.5V, I _D = 2.3A ④	
V _{GS(th)}	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
g _{fs}	Forward Transconductance	5.5			S	$V_{DS} = 10V, I_D = 2.3A$	
1	Drain-to-Source Leakage Current			25		$V_{DS} = 30V, V_{GS} = 0V$	
I _{DSS}				250	μA	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125$ °C	
1	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V	
I _{GSS}				100		V _{GS} = 16V	
Qg	Total Gate Charge		34	50		I _D = 4.6A	
Q _{gs}	Gate-to-Source Charge		4.4	6.5	nC	$V_{DS} = 24V$	
Q _{gd}	Gate-to-Drain ("Miller") Charge		10	16		V_{GS} = 10V, See Fig. 6 and 9 \oplus	
t _{d(on)}	Turn-On Delay Time		7.2			$V_{DD} = 15V$	
t _r	Rise Time		22		ns	$I_D = 4.6A$	
t _{d(off)}	Turn-Off Delay Time		33		115	$R_G = 6.2\Omega$	
t _f	Fall Time		28			$R_D = 3.2\Omega$, See Fig. 10 @	
C _{iss}	Input Capacitance		840			V _{GS} = 0V	
Coss	Output Capacitance		340		pF	$V_{DS} = 25V$	
C _{rss}	Reverse Transfer Capacitance		170			f = 1.0MHz, See Fig. 5	

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current		0	0.91	01	MOSFET symbol	
	(Body Diode)				A	showing the	
I _{SM}	Pulsed Source Current			27		1 ^	integral reverse
	(Body Diode) ①			37		p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C, I _S = 4.6A, V _{GS} = 0V ④	
t _{rr}	Reverse Recovery Time		65	98	ns	$T_J = 25^{\circ}C, I_F = 4.6A$	
Q _{rr}	Reverse RecoveryCharge		160	240	nC	di/dt = 100A/µs ④	
t _{on}	Forward Turn-On Time	Intri	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Specification changes

Rev.#	Parameters	Old spec.	New spec.	Comments	Revision Date
1	V _{GS(th)} (Max.)	2.5V	No spec.	Removed V _{GS(th)} (Max). Specification	11/1/96
1	V _{GS} (Max.)	±20	±16	Decrease V _{GS} (Max). Specification	11/1/96

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} @V_{DD} = 15V, & starting $T_J = 25^{\circ}C$, $L = 13mH$ \\ R_G = 25\Omega, I_{AS} = 4.6A. & (See Figure 12) \\ \end{tabular}$
- $\label{eq:loss} \begin{array}{l} \mbox{ } 3 \mbox{ } I_{SD} \leq 4.6A, \mbox{ } di/dt \leq 110A/\mu s, \mbox{ } V_{DD} \leq V_{(BR)DSS}, \\ \mbox{ } T_{J} \leq 150 \mbox{ } C \end{array}$
- 4 Pulse width \leq 300µs; duty cycle \leq 2%.

International TOR Rectifier

IRLL3303PbF

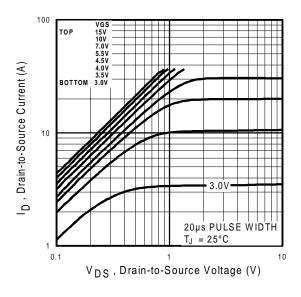


Fig 1. Typical Output Characteristics

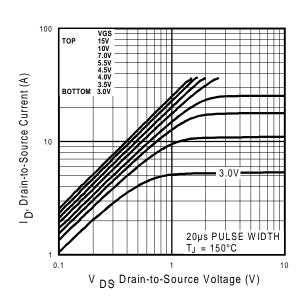


Fig 2. Typical Output Characteristics

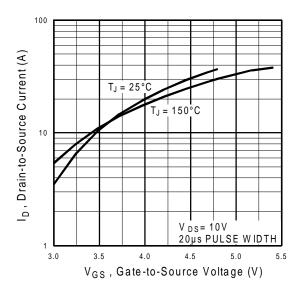


Fig 3. Typical Transfer Characteristics

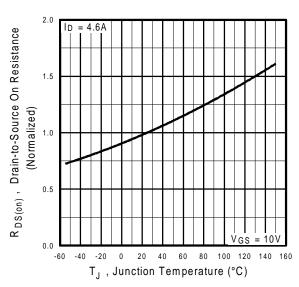


Fig 4. Normalized On-Resistance Vs. Temperature

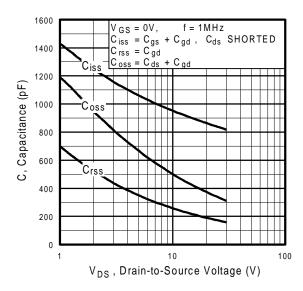


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

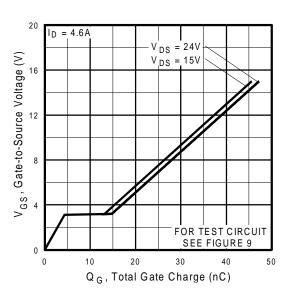


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

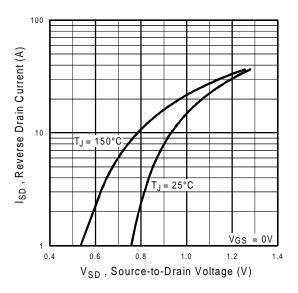


Fig 7. Typical Source-Drain Diode Forward Voltage

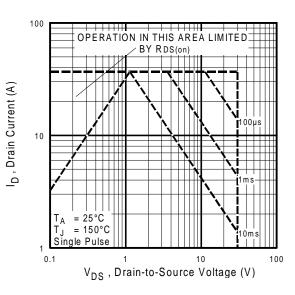


Fig 8. Maximum Safe Operating Area

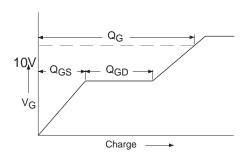


Fig 9a. Basic Gate Charge Waveform

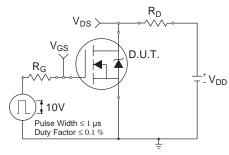
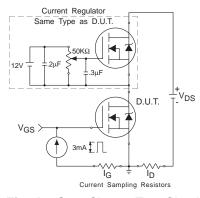


Fig 10a. Switching Time Test Circuit



V_{DS}
90%

10%

V_{GS}

t_{d(on)} t_r

t_{d(off)} t_f

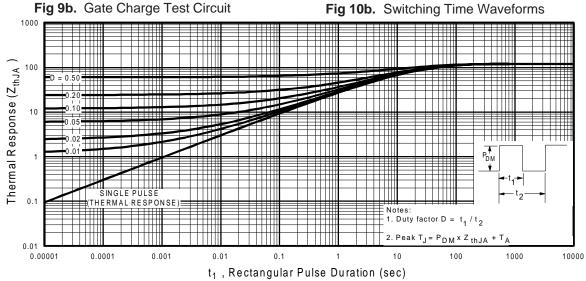


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

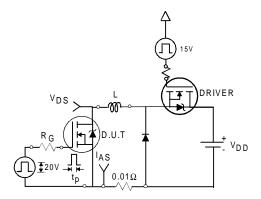


Fig 12a. Unclamped Inductive Test Circuit

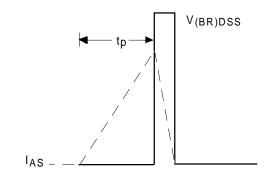


Fig 12b. Unclamped Inductive Waveforms

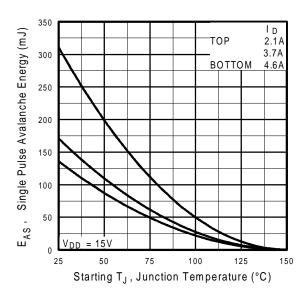
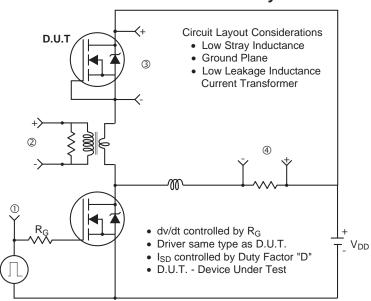
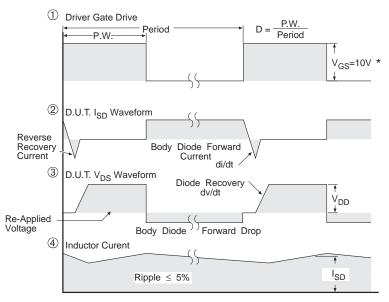


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

Peak Diode Recovery dv/dt Test Circuit





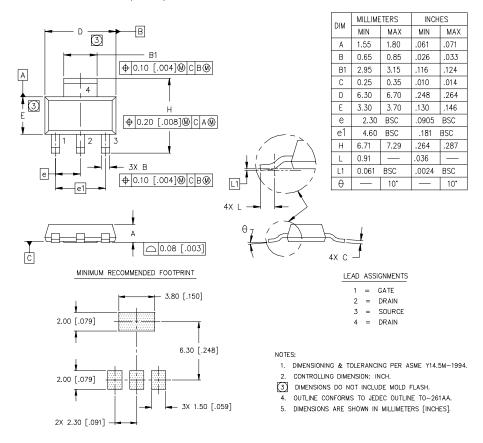
* V_{GS} = 5V for Logic Level Devices

Fig 13. For N-Channel HEXFETS

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SOT-223 (TO-261AA) Package Outline

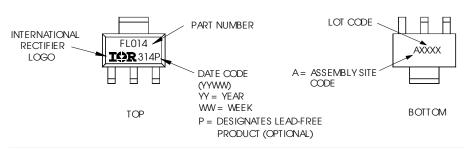
Dimensions are shown in milimeters (inches)



SOT-223 (TO-261AA) Part Marking Information

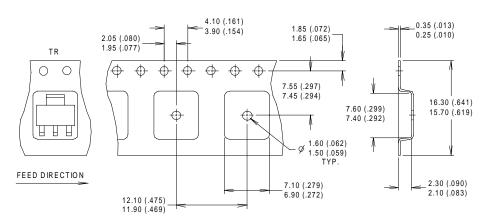
HEXFET PRODUCT MARKING

EXAMPLE: THIS IS AN IRFL014



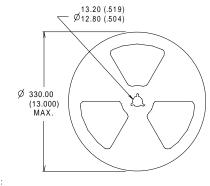
SOT-223 (TO-261AA) Tape & Reel Information

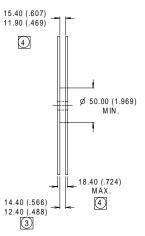
Dimensions are shown in milimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541
- 3. EACH \$\mathre{Q}\$330.00 (13.00) REEL CONTAINS 2,500 DEVICES.





- OUTLINE COMFORMS TO EIA-418-1.
 CONTROLLING DIMENSION: MILLIMETER...

- DIMENSION MEASURED @ HUB.

 DINCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.

International IOR Rectifier

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